

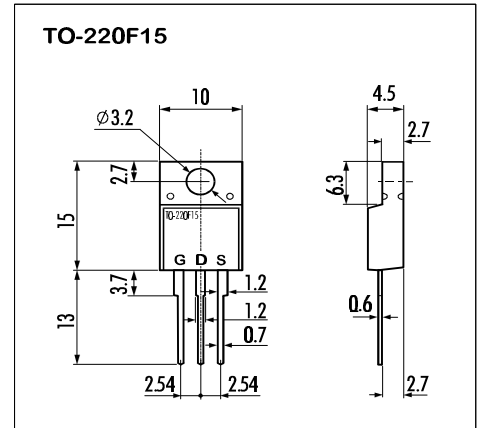
> **Features**

- High Speed Switching
- Low On-Resistance
- No Secondary Breakdown
- Low Driving Power
- High Voltage
- $V_{GS} = \pm 30V$  Guarantee
- Avalanche Proof

> **Applications**

- Switching Regulators
- UPS
- DC-DC converters
- General Purpose Power Amplifier

> **Outline Drawing**

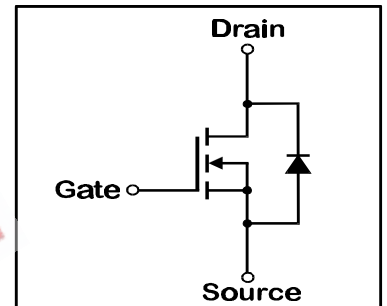


> **Maximum Ratings and Characteristics**

- Absolute Maximum Ratings ( $T_C=25^\circ C$ ), unless otherwise specified

Item	Symbol	Rating	Unit
Drain-Source-Voltage	$V_{DS}$	900	V
Drain-Gate-Voltage( $R_{GS}=20K\Omega$ )	$V_{DGR}$	900	V
Continous Drain Current	$I_D$	5	A
Pulsed Drain Current	$I_{D(puls)}$	20	A
Gate-Source-Voltage	$V_{GS}$	$\pm 30$	V
Max. Power Dissipation	$P_D$	40	W
Operating and Storage Temperature Range	$T_{ch}$	150	$^\circ C$
	$T_{stg}$	-55 ~ +150	$^\circ C$

> **Equivalent Circuit**



- Electrical Characteristics ( $T_C=25^\circ C$ ), unless otherwise specified

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown-Voltage	$V_{(BR)DSS}$	$I_D=1mA$ $V_{GS}=0V$	900			V
Gate Threshold Voltage	$V_{GS(th)}$	$I_D=1mA$ $V_{DS}=V_{GS}$	2,5	3,0	3,5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=900V$ $T_{ch}=25^\circ C$		10	500	$\mu A$
		$V_{GS}=0V$ $T_{ch}=125^\circ C$		0,2	1,0	mA
Gate Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 30V$ $V_{DS}=0V$		10	100	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$I_D=2,5A$ $V_{GS}=10V$		2,7	3,6	$\Omega$
Forward Transconductance	$g_{fs}$	$I_D=2,5A$ $V_{DS}=25V$	2,0	4,0		S
Input Capacitance	$C_{iss}$	$V_{DS}=25V$		750	1150	pF
Output Capacitance	$C_{oss}$	$V_{GS}=0V$		95	145	pF
Reverse Transfer Capacitance	$C_{rss}$	$f=1MHz$		40	60	pF
Turn-On-Time $t_{on}$ ( $t_{on}=t_{d(on)}+t_r$ )	$t_{d(on)}$	$V_{CC}=600V$		20	30	ns
	$t_r$	$I_D=5A$		35	55	ns
Turn-Off-Time $t_{off}$ ( $t_{off}=t_{d(off)}+t_f$ )	$t_{d(off)}$	$V_{GS}=10V$		70	110	ns
	$t_f$	$R_{GS}=10\Omega$		35	55	ns
Avalanche Capability	$I_{AV}$	$L=100\mu H$ $T_{ch}=25^\circ C$	5,0			A
Diode Forward On-Voltage	$V_{SD}$	$I_F=2I_{DR}$ $V_{GS}=0V$ $T_{ch}=25^\circ C$		0,95	1,45	V
Reverse Recovery Time	$t_{rr}$	$I_F=I_{DR}$ $V_{GS}=0V$		1100		ns
Reverse Recovery Charge	$Q_{rr}$	$-dI_F/dt=100A/\mu s$ $T_{ch}=25^\circ C$		5,5		$\mu C$

- Thermal Characteristics

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance	$R_{th(ch-a)}$	channel to air			62,5	$^\circ C/W$
	$R_{th(ch-c)}$	channel to case			3,125	$^\circ C/W$

N-channel MOS-FET			
900V	3,6Ω	5A	40W

# 2SK2527-01MR

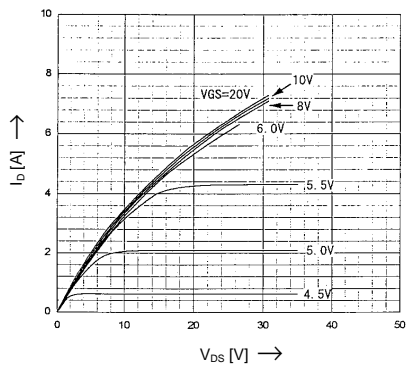
## FAP-II Series



### > Characteristics

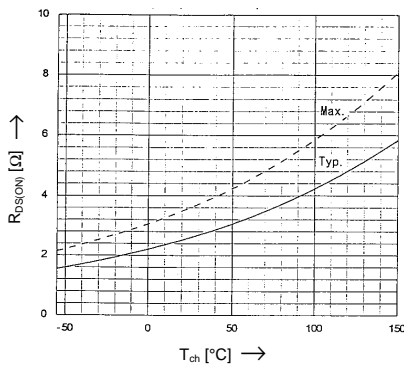
Typical Output Characteristics

$I_D=f(V_{DS})$ ; 80μs pulse test;  $T_C=25^\circ\text{C}$



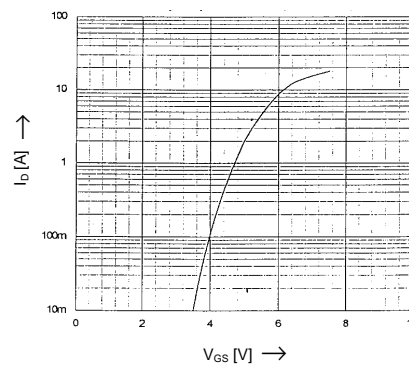
Drain-Source On-State Resistance

$R_{DS(on)}=f(T_{ch})$ ;  $I_D=2.5\text{A}$ ;  $V_{GS}=10\text{V}$



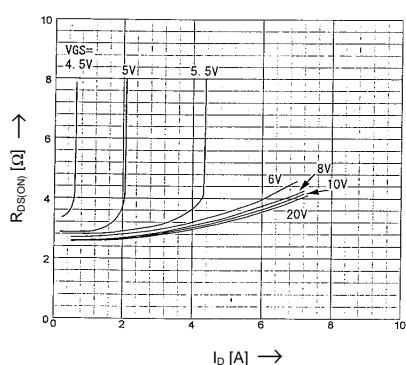
Typical Transfer Characteristics

$I_D=f(V_{GS})$ ; 80μs pulse test;  $V_{DS}=25\text{V}$ ;  $T_C=25^\circ\text{C}$



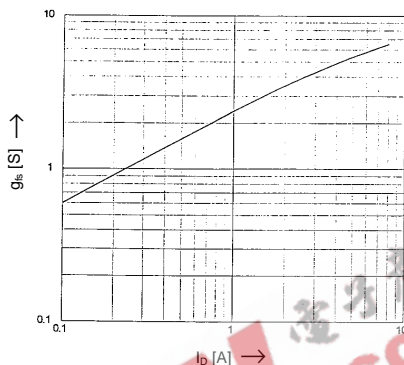
Typical Drain-Source On-State-Resistance

$R_{DS(on)}=f(I_D)$ ;  $T_C=25^\circ\text{C}$



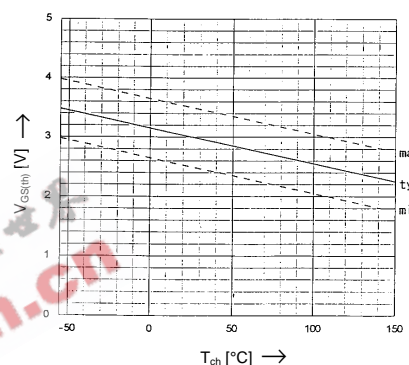
Typical Transconductance

$g_m=f(I_D)$ ; 80μs pulse test;  $V_{DS}=25\text{V}$ ;  $T_C=25^\circ\text{C}$



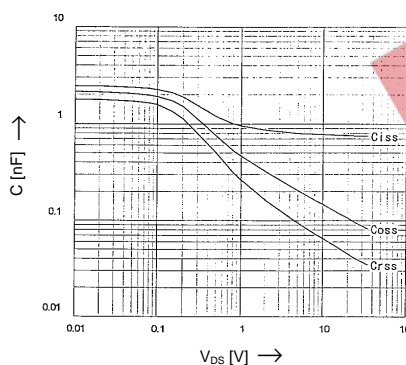
Gate Threshold Voltage

$V_{GS(th)}=f(T_{ch})$ ;  $I_D=1\text{mA}$ ;  $V_{DS}=V_{GS}$



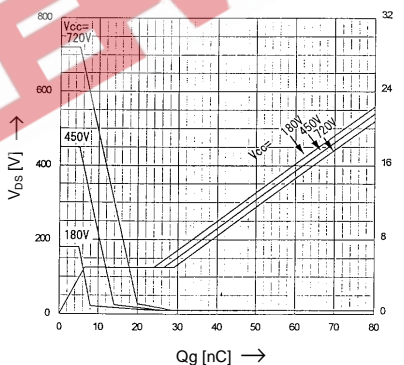
Typical Capacitances

$C=f(V_{DS})$ ;  $V_{GS}=0\text{V}$ ;  $f=1\text{MHz}$



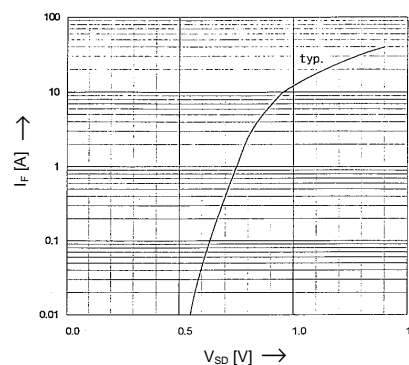
Typical Gate Charge Characteristics

$V_{GS}=f(Q_g)$ ;  $I_D=5\text{A}$



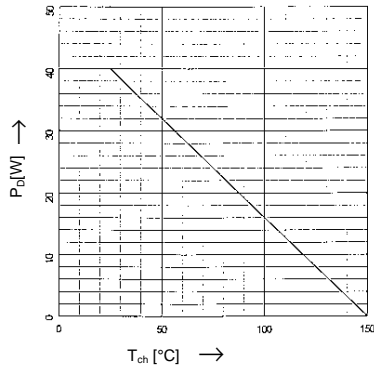
Forward Characteristics of Reverse Diode

$I_F=f(V_{SD})$ ; 80μs pulse test



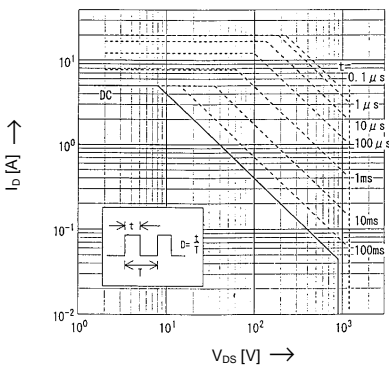
Power Dissipation

$P_D=f(T_C)$



Safe Operation Area

$I_D=f(V_{DS})$ ;  $D=0.01$ ;  $T_C=25^\circ\text{C}$



Transient Thermal impedance

$Z_{th(ch-j)}=f(t)$  parameter:  $D=t/T$

